

RF Exposure Report

Report No.: SA170110C03A

FCC ID: E2K-K02T

Test Model: K02T

Received Date: Jan. 10, 2017

Test Date: Mar. 16 ~ Mar. 17, 2017

Issued Date: Mar. 29, 2017

Applicant: Dell Inc.

Address: One Dell Way, Round Rock, Texas 78682, USA

Issued By: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch

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Release Control Record

| Issue No. | Description | Date Issued |
|--------------|------------------|---------------|
| SA170110C03A | Original release | Mar. 29, 2017 |

1 Certificate of Conformity

Product: Wireless Charging Keyboard
Brand: Dell
Test Model: K02T
Sample Status: Production Unit
Applicant: Dell Inc.
Test Date: Mar. 16 ~ Mar. 17, 2017
Standards: FCC Part 2 (Section 2.1091)
KDB 447498 D01 General RF Exposure Guidance v06
IEEE C95.1

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :  , **Date:** Mar. 29, 2017
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Approved by :  , **Date:** Mar. 29, 2017
Ken Liu / Senior Manager

2 Evaluation Result

Following FCC KDB 447498 D01 “General SAR test exclusion guidance”

The corresponding SAR Exclusion Threshold condition, listed below:

- 1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$$\frac{[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}]}{\leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, 16 where}}$$

- $f(\text{GHz})$ is the RF channel transmit frequency in GHz.
- Power and distance are rounded to the nearest mW and mm before calculation.
- The result is rounded to one decimal place for comparison. The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:

- a) [Threshold at 50 mm in step 1) + (test separation distance - 50mm) · (f(MHz)/150)] mW, at 100MHz to 1500 MHz
- b) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) · 10] mW at > 1500 MHz and ≤ 6 GHz

- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.

- a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(\text{MHz}))]$ for test separation distances > 50 mm and < 200 mm.
- b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances ≤ 50 mm.
- c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.

3 Calculation Result of Maximum Conducted Power

| Mode | Max. Power (mW) | Min. test separation distance (mm) | SAR test exclusion calculation value ^(NOTE 2) | 10-g extremity SAR test exclusion thresholds | Result |
|---------------|-----------------|------------------------------------|--|--|--------|
| 2.402 ~ 2.480 | 1.5 | 5 | 0.465 | 7.5 | Pass |

NOTE: 1. The antenna type is Ceramic antenna with 0.5dBi gain.
2. Calculate SAR test exclusion thresholds from condition "1" formulas.

4 Conclusion

Since Source-base time average power is below SAR test exclusion power thresholds, the SAR evaluation is not required.

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